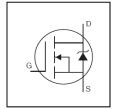


AUIRFR3504Z

HEXFET® Power MOSFET

Features

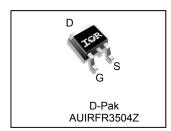
- Advanced Process Technology
- Low On-Resistance
- 175°C Operating Temperature
- Fast Switching
- · Repetitive Avalanche Allowed up to Timax
- Lead-Free, RoHS Compliant
- Automotive Qualified *



V _{DSS}	40V
R _{DS(on)} max.	9.0mΩ
D (Silicon Limited)	77A
D (Package Limited)	42A

Description

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.



G	D	S
Gate	Drain	Source

Page part number	Dookogo Typo	Standard Pack	Orderable Part Number		
Base part number	Package Type	Form	Quantity	Orderable Part Number	
AUIRFR3504Z	D. Dak	Tube	75	AUIRFR3504Z	
AUIRER3504Z	D-Pak	Tape and Reel Left	3000	AUIRFR3504ZTRL	

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

Symbol	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	77	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	54	A
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Package Limited) 42		
I _{DM}	Pulsed Drain Current ①	310]
P _D @T _C = 25°C	Maximum Power Dissipation	90	W
	Linear Derating Factor	0.60	W/°C
V_{GS}	Gate-to-Source Voltage	± 20	V
E _{AS}	Single Pulse Avalanche Energy (Thermally Limited) ②	77	ma I
E _{AS} (Tested) Single Pulse Avalanche Energy Tested Value ©		110	- mJ
I _{AR}	Avalanche Current ①	See Fig.15,16, 12a, 12b	Α
E _{AR}	Repetitive Avalanche Energy ®		mJ
T_J	perating Junction and -55 to + 175		
T _{STG}	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	

Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
$R_{ heta JC}$	Junction-to-Case ®		1.66	
$R_{\theta JA}$	Junction-to-Ambient (PCB Mount) ⑦		50	°C/W
$R_{\theta JA}$	Junction-to-Ambient		110	

HEXFET® is a registered trademark of Infineon.

2015-11-23

^{*}Qualification standards can be found at www.infineon.com



Static @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	40			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.032		V/°C	Reference to 25°C, I _D = 1mA
R _{DS(on)}	Static Drain-to-Source On-Resistance		8.23	9.0	mΩ	V _{GS} = 10V, I _D = 42A ④
$V_{GS(th)}$	Gate Threshold Voltage	2.0		4.0	V	$V_{DS} = V_{GS}$, $I_D = 250\mu A$
gfs	Forward Trans conductance	32			S	$V_{DS} = 10V, I_{D} = 42A $ ④
	Drain-to-Source Leakage Current			20		$V_{DS} = 40V, V_{GS} = 0V$
I _{DSS}	Dialii-to-Source Leakage Current			250	μΑ	$V_{DS} = 40V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
	Gate-to-Source Forward Leakage			200	- Δ	$V_{GS} = 20V$
I _{GSS}	Gate-to-Source Reverse Leakage			-200	nA	$V_{GS} = -20V$

Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

		_	_		
Total Gate Charge		30	45		I _D = 42A
Gate-to-Source Charge		9.6		nC	$V_{DS} = 32V$
Gate-to-Drain Charge		12			V _{GS} = 10V4
Turn-On Delay Time		15			$V_{DD} = 20V$
Rise Time		74		200	I _D = 42A
Turn-Off Delay Time		30		115	$R_G = 15\Omega$
Fall Time		38			V _{GS} = 10V4
Internal Drain Inductance		4.5			Between lead, 6mm (0.25in.)
Internal Source Inductance		7.5			from package and center of die contact
Input Capacitance		1510			$V_{GS} = 0V$
Output Capacitance		340			$V_{DS} = 25V$
Reverse Transfer Capacitance		190		nE	f = 1.0MHz, See Fig.5
Output Capacitance		1100		þΓ	$V_{GS} = 0V$, $V_{DS} = 1.0V$ $f = 1.0MHz$
Output Capacitance		340			$V_{GS} = 0V$, $V_{DS} = 32V$ $f = 1.0MHz$
Effective Output Capacitance		460			V_{GS} = 0V, V_{DS} = 0V to 32V
	Gate-to-Source Charge Gate-to-Drain Charge Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Internal Drain Inductance Input Capacitance Output Capacitance Reverse Transfer Capacitance Output Capacitance Output Capacitance Output Capacitance Output Capacitance Output Capacitance	Gate-to-Source Charge —— Gate-to-Drain Charge —— Turn-On Delay Time —— Rise Time —— Turn-Off Delay Time —— Fall Time —— Internal Drain Inductance —— Input Capacitance —— Output Capacitance —— Reverse Transfer Capacitance —— Output Capacitance ——	Gate-to-Source Charge — 9.6 Gate-to-Drain Charge — 12 Turn-On Delay Time — 15 Rise Time — 74 Turn-Off Delay Time — 30 Fall Time — 38 Internal Drain Inductance — 4.5 Internal Source Inductance — 7.5 Input Capacitance — 340 Reverse Transfer Capacitance — 190 Output Capacitance — 1100 Output Capacitance — 340	Gate-to-Source Charge — 9.6 — Gate-to-Drain Charge — 12 — Turn-On Delay Time — 15 — Rise Time — 74 — Turn-Off Delay Time — 30 — Fall Time — 38 — Internal Drain Inductance — 4.5 — Internal Source Inductance — 7.5 — Input Capacitance — 340 — Reverse Transfer Capacitance — 190 — Output Capacitance — 1100 — Output Capacitance — 340 —	Gate-to-Source Charge — 9.6 — nC Gate-to-Drain Charge — 12 — Turn-On Delay Time — 15 — Rise Time — 74 — Turn-Off Delay Time — 30 — Fall Time — 38 — Internal Drain Inductance — 4.5 — Input Capacitance Inductance — 7.5 — Input Capacitance — 340 — Output Capacitance — 190 — Output Capacitance — 1100 — Output Capacitance — 340 —

Diode Characteristics

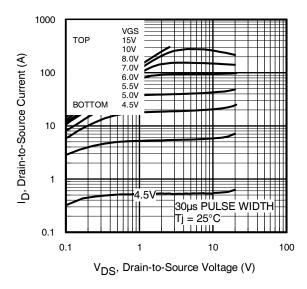
	Parameter	Min.	Тур.	Max.	Units	Conditions
I _S	Continuous Source Current (Body Diode)			42		MOSFET symbol showing the
I _{SM}	Pulsed Source Current (Body Diode) ①			310		integral reverse p-n junction diode.
V_{SD}	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C, I_S = 42A, V_{GS} = 0V $
t _{rr}	Reverse Recovery Time		18	27	ns	$T_J = 25^{\circ}C$, $I_F = 42A$, $V_{DD} = 20V$
Q_{rr}	Reverse Recovery Charge		9.2	14	nC	di/dt = 100A/µs④
t _{on}	Forward Turn-On Time	Intrinsio	turn-or	time is	negligil	ole (turn-on is dominated by L _S +L _D)

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- ② Limited by T_{Jmax} , starting $T_J = 25$ °C, L = 0.09mH, $R_G = 25\Omega$, $I_{AS} = 42$ A, $V_{GS} = 10$ V. Part not recommended for use above this value.
- \oplus C_{oss} eff. is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}
- © Limited by T_{Jmax}, see Fig.12a, 12b, 15, 16 for typical repetitive avalanche performance.
- ⑥ This value determined from sample failure population, starting $T_J = 25^{\circ}C$, L = 0.09mH, R_G = 25 Ω , I_{AS} = 42A, V_{GS} =10V.
- When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994
- \otimes R₀ is measured at T_J approximately 90°C.

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1000

TOP 15V
10V
8.0V
7.0V
6.0V
5.5V
80TOM 4.5V
10
30µs PULSE WIDTH
Tj = 175°C
10

VDS, Drain-to-Source Voltage (V)

Fig. 1 Typical Output Characteristics

Fig. 2 Typical Output Characteristics

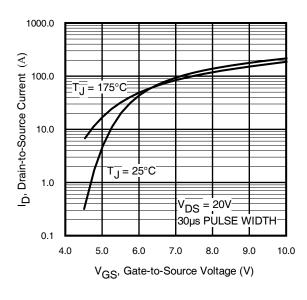


Fig. 3 Typical Transfer Characteristics

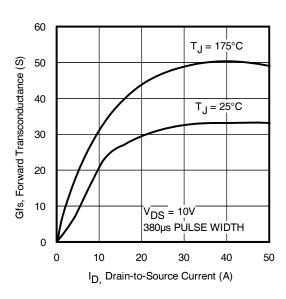


Fig. 4 Typical Forward Trans conductance Vs. Drain Current



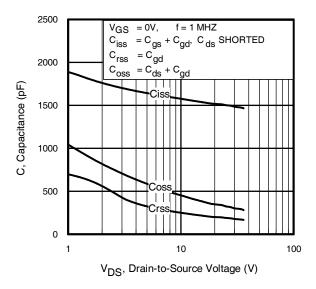


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

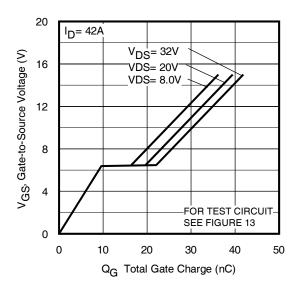


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

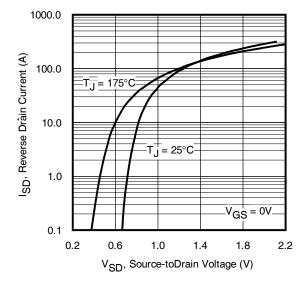


Fig. 7 Typical Source-to-Drain Diode Forward Voltage

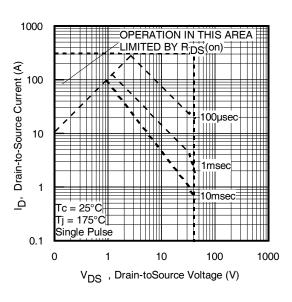
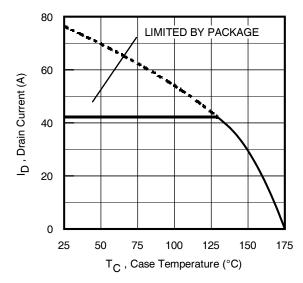


Fig 8. Maximum Safe Operating Area





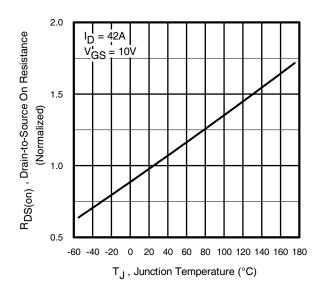


Fig 9. Maximum Drain Current Vs. Case Temperature

Fig 10. Normalized On-Resistance Vs. Temperature

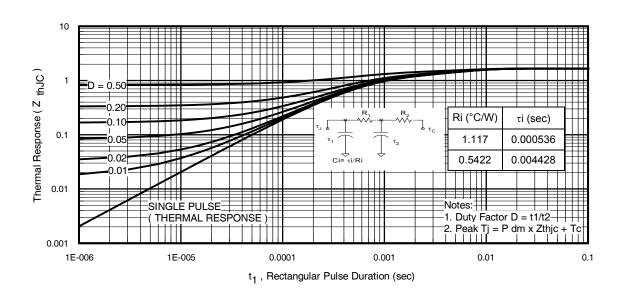


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case



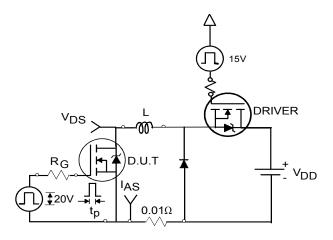


Fig 12a. Unclamped Inductive Test Circuit

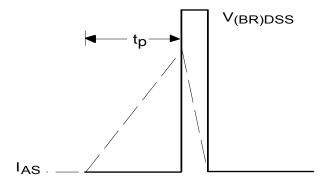


Fig 12b. Unclamped Inductive Waveforms

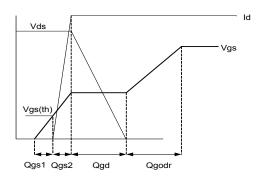


Fig 13a. Gate Charge Waveform

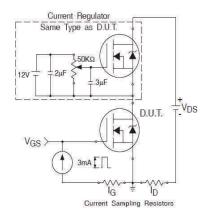


Fig 13b. Gate Charge Test Circuit

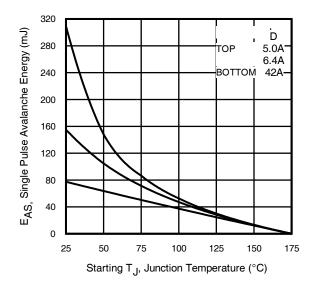


Fig 12c. Maximum Avalanche Energy vs. Drain Current

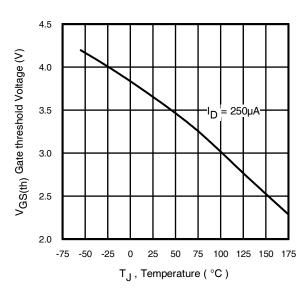


Fig 14. Threshold Voltage Vs. Temperature



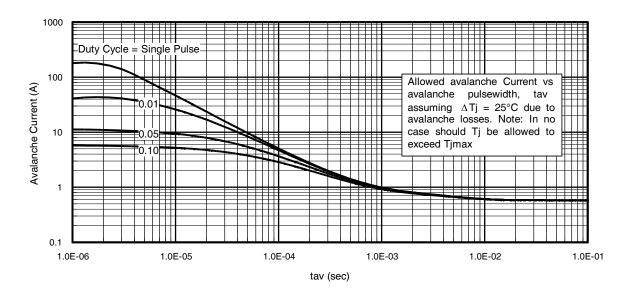


Fig 15. Typical Avalanche Current Vs. Pulse width

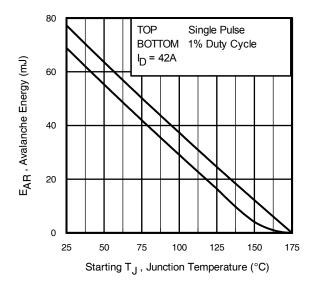


Fig 16. Maximum Avalanche Energy Vs. Temperature

Notes on Repetitive Avalanche Curves , Figures 15, 16:

(For further info, see AN-1005 at www.infineon.com)

- Avalanche failures assumption:
 Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{imax}. This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long as T_{jmax} is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 12a, 12b.
- 4. PD (ave) = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. Iav = Allowable avalanche current.
- 7. ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 15, 16).

tav = Average time in avalanche.

D = Duty cycle in avalanche = tav ·f

ZthJC(D, tav) = Transient thermal resistance, see Figures 13)

$$\begin{split} P_{D \; (ave)} &= 1/2 \; (\; 1.3 \cdot BV \cdot I_{av}) = \Delta T / \; Z_{thJC} \\ I_{av} &= 2\Delta T / \; [1.3 \cdot BV \cdot Z_{th}] \\ E_{AS \; (AR)} &= P_{D \; (ave)} \cdot t_{av} \end{split}$$



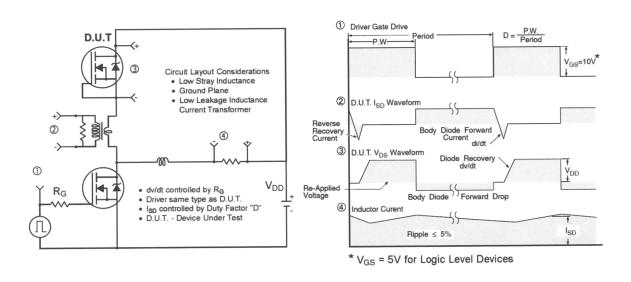


Fig 17. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

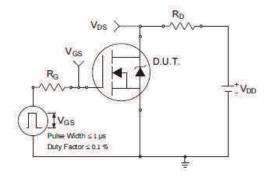


Fig 18a. Switching Time Test Circuit

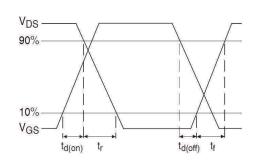
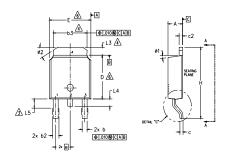


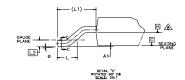
Fig 18b. Switching Time Waveforms

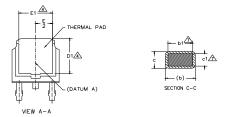


D-Pak (TO-252AA) Package Outline (Dimensions are shown in millimeters (inches))









NOTES:

- 1.- DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2.- DIMENSION ARE SHOWN IN INCHES [MILLIMETERS].
- 3- LEAD DIMENSION UNCONTROLLED IN L5.
- A- DIMENSION D1, E1, L3 & b3 ESTABLISH A MINIMUM MOUNTING SURFACE FOR THERMAL PAD.
- 5.— SECTION C-C DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN .005 AND 0.10 [0.13 AND 0.25] FROM THE LEAD TIP.
- ⚠ DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005 [0.13] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
- A- DIMENSION 61 & c1 APPLIED TO BASE METAL ONLY.
- ♠ DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
- 9.- OUTLINE CONFORMS TO JEDEC OUTLINE TO-252AA.

S					N	
Y M	DIMENSIONS					
B	MILLIM	ETERS	INC	INCHES		
L	MIN.	MAX.	MIN.	MAX.	O T E S	
Α	2.18	2.39	.086	.094		
A1	-	0.13	-	.005		
b	0.64	0.89	.025	.035		
ь1	0.65	0.79	.025	.031	7	
b2	0.76	1.14	.030	.045		
b3	4.95	5.46	.195	.215	4	
С	0.46	0.61	.018	.024		
c1	0.41	0.56	.016	.022	7	
c2	0.46	0.89	.018	.035		
D	5.97	6.22	.235	.245	6	
D1	5.21	-	.205	-	4	
Ε	6.35	6.73	.250	.265	6	
E1	4.32	-	.170	-	4	
e	2.29	BSC	.090	BSC		
Н	9.40	10.41	.370	.410		
L	1.40	1.78	.055	.070		
L1	2.74	BSC	.108	REF.		
L2	0.51	BSC	.020	BSC		
L3	0.89	1.27	.035	.050	4	
L4	-	1.02	-	.040		
L5	1.14	1.52	.045	.060	3	
ø	0.	10°	0,	10°		
ø1	0,	15*	0,	15*		
ø2	25*	35°	25*	35*		

LEAD ASSIGNMENTS

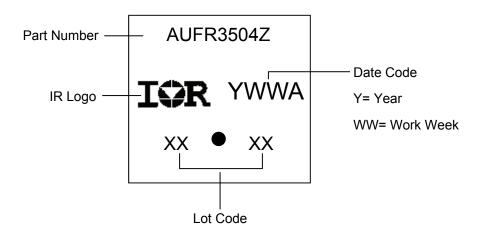
HEXFET

- 1.- GATE
- 2.- DRAIN
- 3.- SOURCE
- 4.- DRAIN

IGBT & CoPAK

- 1.- GATE
- 2.- COLLECTOR 3.- EMITTER
- 4. COLLECTOR

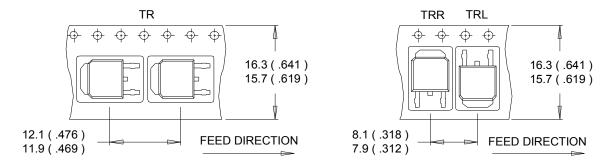
D-Pak (TO-252AA) Part Marking Information



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

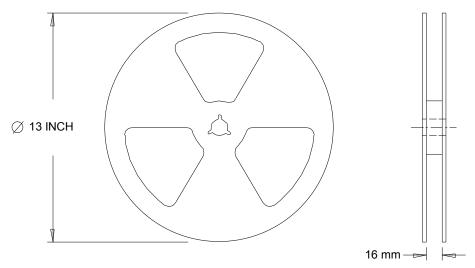


D-Pak (TO-252AA) Tape & Reel Information (Dimensions are shown in millimeters (inches))



NOTES:

- 1. CONTROLLING DIMENSION: MILLIMETER.
- 2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
- 3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



NOTES:

1. OUTLINE CONFORMS TO EIA-481.

Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



Qualification Information

Qualification Level (per AEC-Q101) Comments: This part number(s) passed Automotive qualification. Industrial and Consumer qualification level is granted by extension of Automotive level. Moisture Sensitivity Level D-Pak MSL1					
Qualification Level Comments: This part number(s) passed Automotive qualification. Industrial and Consumer qualification level is granted by extension of Automotive level. Moisture Sensitivity Level D-Pak MSL1	Automotive				
Industrial and Consumer qualification level is granted by extension of Automotive level. Moisture Sensitivity Level D-Pak MSL1	(per AEC-Q101)				
Industrial and Consumer qualification level is granted by extension of Automotive level. Moisture Sensitivity Level D-Pak MSL1	Infineon's				
Automotive level. Moisture Sensitivity Level D-Pak MSL1					
	J				
Class M4 [†]					
Manatatana Mandal	Class M4 [†]				
Machine Model AEC-Q101-002	AEC-Q101-002				
Class H1C [†]	Class H1C [†]				
Human Body Model AEC-Q101-001	AEC-Q101-001				
Class C5 [†]					
Charged Device Model AEC-Q101-005	AEC-Q101-005				
RoHS Compliant Yes					

[†] Highest passing voltage.

Revision History

Date	Comments
11/23/2015	Updated datasheet with corporate template
11/23/2013	Corrected ordering table on page 1.

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